## Application/Control No. Applicant(s)/Patent Under Reexamination 10/063,976 WEI ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Kenneth J. Ramsey 2879 **U.S. PATENT DOCUMENTS Document Number** Date Name Country Code-Number-Kind Code MM-YYYY Classification US-4,431,923 Α 02-1984 Wang et al. 250/491.1 US-5,326,420 07-1994 В Vinouze et al. 156/379 С US-5,936,253 08-1999 Sugaya, Ayako 250/548 US-6,049,167 D 04-2000 Onitsuka et al. 313/512 Ε US-US-F G US-US-Н US-1 US-J Κ US-US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Classification Country Code-Number-Kind Code Name MM-YYYY Ν 0 Р O R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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